

| | | | |
|-----------------------------------|-------------------------|---|-------------|
| Notice of References Cited | Application/Control No. | Applicant(s)/Patent Under Reexamination | |
| | 10/672,559 | SATURNO, EMILIO | |
| | Examiner | Art Unit | Page 1 of 1 |
| Jes F. Pascua | 3727 | | |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| | A | US-4,006,764 | 02-1977 | Yamamoto et al. | 206/320 |
| | B | US-4,768,247 | 09-1988 | Beier, John K. | 5/640 |
| | C | US-6,049,938 A | 04-2000 | Jimison, James W. | 15/210.1 |
| | D | US-6,594,838 B1 | 07-2003 | Hollander et al. | 5/636 |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.